

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/625,824	CHANG ET AL.	
Examiner		Art Unit		Page 1 of 1
Eunhee Kim		2123		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0010543	01-2002	Watanabe et al.	701/211
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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